Notice of References Cited Application/Control No. 10/562,803 Examiner Narayan K. Bhat Applicant(s)/Patent Under Reexamination GAO ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,843,640	12-1998	Patterson et al.	435/5
*	В	US-5,567,809	10-1996	Apple et al.	536/24.3
*	С	US-2002/0051973	05-2002	DELENSTARR et al.	435/6
*	D	US-2002/0086289	07-2002	STRAUS, DON	435/6
	E	US-			
	F	US-			
	G	US-			
	Ι	US-			
	ı	US-			
	7	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					·
	Р				·	
	Q					
	R					
	s					
	Т					,

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	ט	Trau et al, Genotyping on a complementary metal oxide semiconductor silicon polymerase chain reaction chip with integrated DNA microarray, 2002, Anal. Chem., 74, 3168-3173.					
	٧	Samartzidou et al, Lucidea microarray scorecard: An integrated tool for validation of microarray gene expression experiments, 2001, Life science news, 8, 1-3.					
	w						
	х						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.